

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	09/995,770	YAMANO, AKIRA
	<b>Examiner</b> Vu B. Hang	<b>Art Unit</b> 2622

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner